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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO	
10/068,004	02/08/2002	Woo Young So	1514.1010	6442	
21171	7590 08/01/2003				
STAAS & HALSEY LLP SUITE 700			EXAMINER		
1201 NEW Y	ORK AVENUE, N.W.		SEFER, AHMED N		
	ON, DC 20005		ART UNIT	PAPER NUMBER	
			2826		
			DATE MAILED: 08/01/2003		

Please find below and/or attached an Office communication concerning this application or proceeding.

,		Application No.	Applicant(s)	11/
		10/068,004	SO ET AL.	M
	Office Action Summary	Examin r	Art Unit	
		A. Sefer	2826	
Peri d f	The MAILING DATE of this communicati n appr r Reply	pears on the cover sheet with the	c rresp ndence add	dress
I HE I - Exte after - If the - If NO - Failu - Any I	ORTENED STATUTORY PERIOD FOR REPLY MAILING DATE OF THIS COMMUNICATION. nsions of time may be available under the provisions of 37 CFR 1.1 SIX (6) MONTHS from the mailing date of this communication. It period for reply specified above is less than thirty (30) days, a reply period for reply is specified above, the maximum statutory period or re to reply within the set or extended period for reply will, by statute reply received by the Office later than three months after the mailing and patent term adjustment. See 37 CFR 1.704(b).	36(a). In no event, however, may a reply be t y within the statutory minimum of thirty (30) de will apply and will expire SIX (6) MONTHS from	imely filed ays will be considered timely. In the mailing date of this con	mmunication.
1)⊠	Responsive to communication(s) filed on 3/3/	<u>03</u> .		
2a) <u></u> ☐	This action is FINAL . 2b)⊠ Th	is action is non-final.		
3) 🗌	Since this application is in condition for allowationsed in accordance with the practice under on of Claims	ance except for formal matters in	prosecution as to the 453 O.G. 213.	merits is
	Claim(s) <u>12-16 and 22-25</u> is/are pending in the	o oneliaction		
	4a) Of the above claim(s) is/are withdrawClaim(s) is/are allowed.	vn from consideration.		
	Claim(s) <u>12-16 and 22-25</u> is/are rejected.			
	Claim(s) is/are objected to.			
	Claim(s) are subject to restriction and/or	coloction requirement		
Application	on Papers	election requirement.		
9)[] 7	The specification is objected to by the Examiner	·.		
	he drawing(s) filed on is/are: a)☐ accep		miner	0
	Applicant may not request that any objection to the			
11)[] T	he proposed drawing correction filed on	is: a) ☐ approved b) ☐ disappro		
	If approved, corrected drawings are required in rep			
12)[] T	he oath or declaration is objected to by the Exa	aminer.		
Priority u	nder 35 U.S.C. §§ 119 and 120			
13) 🔲 .	Acknowledgment is made of a claim for foreign	priority under 35 U.S.C. § 119(a	a)-(d) or (f).	
	☑All b)☐ Some * c)☐ None of:		, , , , ,	
	1. Certified copies of the priority documents	have been received.		
	2. Certified copies of the priority documents	have been received in Applicati	on No	
	B. Copies of the certified copies of the priori application from the International Bure the attached detailed Office action for a list of	ty documents have been receive eau (PCT Rule 17.2(a))	ed in this National S	tage
	knowledgment is made of a claim for domestic			pplication)
_ a)	The translation of the foreign language proveknowledgment is made of a claim for domestic	risional application has been rec	eived.	pp
Attachment(
2) 🔲 Notice	of References Cited (PTO-892) of Draftsperson's Patent Drawing Review (PTO-948) ation Disclosure Statement(s) (PTO-1449) Paper No(s)	5) Notice of Informal F	(PTO-413) Paper No(s). Patent Application (PTO-	152)

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DETAILED ACTION

Response to Amendment

1. The amendment filed on 3/3/03 has been entered; no new claims have been added.

Allowable Subject Matter

The indicated allowability of claims 22-25 is withdrawn in view of the newly discovered reference(s) to Yoneda et al. USPN 5,837,568. Rejections based on the newly cited reference(s) follow.

Claim Rejections - 35 USC § 102

2. The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless -

- (b) the invention was patented or described in a printed publication in this or a foreign country or in public use or on sale in this country, more than one year prior to the date of application for patent in the United States.
- -3.——Claims-12-14-are-rejected-under-35-U-S.C. 102(b)-as-being-anticipated by-Yoneda-et-al.

 USPN 5,837,568

Yoneda et al disclose in figs. 12 and 13 a in thin film transistor (TFT), comprising: a substrate 10; a semiconductor layer formed over said substrate having end portions; a first insulating layer 12 disposed on said semiconductor layer so as to expose ones of the end portions of said semiconductor layer; a gate electrode 13 formed over said first insulating layer; a capping layer 14 formed over said gate electrode; spacers 15 formed over said first insulating layer and on both sidewall portions of said gate electrode and said capping layer; high-density source and drain regions 11 formed at the ones of the end portions of said semiconductor layer exposed

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beyond said spacers; source and drain electrodes 17/18 which directly contact, respectively, said high density source and drain regions.

Regarding claim 13, Yoneda et al disclose low-density source and drain regions 11L having a same conductivity as high-density source and drain regions formed at regions of said semiconductor layer under spacers between the gate electrode and the high density source and drain regions, wherein said semiconductor layer has lightly doped drain (LDD) regions under said spacers.

Regarding claim 14, Yoneda et al disclose said first insulating layer, said capping layer and said spacer are of an oxide.

4. Claims 22 and 23 are rejected under 35 U.S.C. 102(b) as being anticipated by Yoneda et al. USPN 5,837,568

Yoneda et al disclose in figs. 12 and 13 an active matrix display device, comprising: a substrate 10; a semiconductor layer having end portions formed over said substrate; a first insulating layer 12 formed over said semiconductor layer so as to expose one of the end portions of said semiconductor layer; a gate electrode 13 formed over said first insulating layer; a capping layer 14 formed over said gate electrode; spacers 15 formed over said first insulating layer and on side wall portions of said gate electrode and said capping layer; high-density source and drain regions 11 formed at the ones of the end portions of said semiconductor layer exposed beyond said spacers; source and drain electrodes 17/18 which directly contact, respectively, said high density source and drain regions; a planarization layer 19 having an opening portion CT3 which exposes a portion of one of said source and drain electrodes; and a pixel electrode

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20 formed on the planarization layer, the pixel electrode contacting one of the second source and drain electrodes through the opening portion.

Regarding claim 23, Yoneda et al disclose low-density source and drain regions having a same conductivity as said high-density source and drain regions formed at off-set regions of said semiconductor layer under said spacers so as to have said semiconductor layer with lightly doped drain (LDD) regions under said spacers.

Claim Rejections - 35 USC § 103

- 5. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:
 - (a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.
- 6. Claims 15, 16 and 24 are rejected under 35 U.S.C. 103(a) as being unpatentable over Yoneda et al. in view of Yamazaki et al.

Yoneda et al disclose the device structure as recited in the claim, but do not disclose a silicide layer.

Yamazaki et al disclose in fig. 1 a silicide layer 105a or a refractory metal (as in claim 16) formed between said source electrode and said high-density source region and between said drain electrode and said high-density drain region.

Therefore, it would have been obvious to one skilled in the art at the time the invention was made to incorporate the teachings of Yamazaki et al with the device of Yoneda et al, since that would lessen the source/drain regions in sheet resistance as taught by Yamazaki et al.

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7. Claim 25 is rejected under 35 U.S.C. 103(a) as being unpatentable over Yoneda et al. in

view of Yamazaki et al as applied to claim 22 above, and further in view of Tang et al. USPN

5,550,066.

The combined references fail to disclose an organic electro-luminescence EL layer and a

cathode electrode.

Tang et al disclose an organic electro-luminescence (EL) layer 82 and a cathode electrode

84 sequentially formed on a first predetermined area of said pixel electrode and on a second

predetermined area of a planarization layer 74.

Therefore, it would have been obvious to one skilled in the art at the time the invention

was made to incorporate the teachings of Tang et al with the device of Yoneda et al and

Yamazaki et al, since that would provide a high efficiency.

Any inquiry concerning this communication or earlier communications from the

examiner should be directed to A. Sefer whose telephone number is (703) 605-1227.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's

supervisor, Nathan Flynn can be reached on (703) 308-6601.

ANS

July 23, 2003

NATHAN J. FLYNN SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 2800 Page 5